R&S®RTA4000 OSCILLOSCOPE

Specifications



Mess- und Prüftechnik. Die Experten.

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Definitions

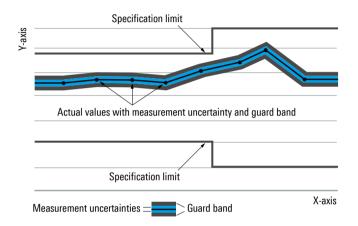
General

Product data applies under the following conditions:

- · Three hours storage at ambient temperature followed by 30 minutes warm-up operation
- Specified environmental conditions met
- · Recommended calibration interval adhered to
- All internal automatic adjustments performed, if applicable

Specifications with limits

Represent warranted product performance by means of a range of values for the specified parameter. These specifications are marked with limiting symbols such as $\langle, \leq, \rangle, \geq, \pm$, or descriptions such as maximum, limit of, minimum. Compliance is ensured by testing or is derived from the design. Test limits are narrowed by guard bands to take into account measurement uncertainties, drift and aging, if applicable.



Non-traceable specifications with limits (n. trc.)

Represent product performance that is specified and tested as described under "Specifications with limits" above. However, product performance in this case cannot be warranted due to the lack of measuring equipment traceable to national metrology standards. In this case, measurements are referenced to standards used in the Rohde & Schwarz laboratories.

Specifications without limits

Represent warranted product performance for the specified parameter. These specifications are not specially marked and represent values with no or negligible deviations from the given value (e.g. dimensions or resolution of a setting parameter). Compliance is ensured by design.

Typical data (typ.)

Characterizes product performance by means of representative information for the given parameter. When marked with <, > or as a range, it represents the performance met by approximately 80 % of the instruments at production time. Otherwise, it represents the mean value.

Nominal values (nom.)

Characterize product performance by means of a representative value for the given parameter (e.g. nominal impedance). In contrast to typical data, a statistical evaluation does not take place and the parameter is not tested during production.

Measured values (meas.)

Characterize expected product performance by means of measurement results gained from individual samples.

Uncertainties

Represent limits of measurement uncertainty for a given measurand. Uncertainty is defined with a coverage factor of 2 and has been calculated in line with the rules of the Guide to the Expression of Uncertainty in Measurement (GUM), taking into account environmental conditions, aging, wear and tear.

Device settings and GUI parameters are designated with the format "parameter: value".

Non-traceable specifications with limits, typical data as well as nominal and measured values are not warranted by Rohde & Schwarz.

In line with the 3GPP/3GPP2 standard, chip rates are specified in million chips per second (Mcps), whereas bit rates and symbol rates are specified in billion bits per second (Gbps), million bits per second (Mbps), thousand bits per second (kbps), million symbols per second (Msps) or thousand symbols per second (ksps), and sample rates are specified in million samples per second (Msample/s). Gbps, Mcps, Mbps, Msps, ksps and Msample/s are not SI units.

Base unit

Vertical system

Input channels	R&S [®] RTA4004	4 channels
Input impedance		50 Ω ± 1.5 % (meas.)
		1 MΩ ± 1 % 14 pF ± 1 pF (meas.)
Analog bandwidth (–3 dB)	at 50 Ω input impedance	
o ()	R&S [®] RTA4004	> 200 MHz
	R&S [®] RTA4004 with -B243 option	> 350 MHz
	R&S [®] RTA4004 with -B245 option	> 500 MHz
	R&S [®] RTA4004 with -B2410 option	> 1 GHz
	at 1 MΩ input impedance	-
	R&S [®] RTA4004 with	> 200 MHz (meas.)
	R&S [®] RTA4004 with -B243 option	> 350 MHz (meas.)
	R&S [®] RTA4004 with -B245 option	> 500 MHz (meas.)
	R&S [®] RTA4004 with -B2410 option	> 500 MHz (meas.)
Lower frequency limit (–3 dB)	at AC coupling	< 5 Hz (meas.)
Analog bandwidth limits	at 50 Ω input impedance	
	R&S [®] RTA4004	20 MHz, 100 MHz
	R&S [®] RTA4004 with -B243 option	20 MHz, 100 MHz, 200 MHz
	R&S [®] RTA4004 with -B245 option	20 MHz, 100 MHz, 200 MHz, 350 MHz
	R&S [®] RTA4004 with -B2410 option	20 MHz, 100 MHz, 200 MHz, 350 MHz
		500 MHz
	at 1 M Ω input impedance	
	R&S®RTA4004	20 MHz, 100 MHz
	R&S®RTA4004 with -B243 option	20 MHz, 100 MHz, 200 MHz
	R&S®RTA4004 with -B245 option and	20 MHz, 100 MHz, 200 MHz, 350 MHz
	R&S [®] RTA4004 with -B243 option	20 Wi 12, 100 Wi 12, 200 Wi 12, 330 Wi 12
Rise time (calculated)	R&S®RTA4004	< 1.75 ns
	R&S®RTA4004 with -B243 option	<1 ns
	R&S®RTA4004 with -B245 option	< 700 ps
	R&S®RTA4004 with -B243 option	< 350 ps
	Ras R1A4004 Will - 62410 0pilon	
Vartical resolution		10 hit up to 16 hit with high recolution
Vertical resolution		10 bit, up to 16 bit with high resolution
		decimation
Invert signal	offect and position = 0	
	offset and position = 0	decimation yes
Invert signal	maximum operating temperature change o	decimation yes f ±5 °C after self-alignment
Invert signal	maximum operating temperature change o input sensitivity > 5 mV/div	decimation yes f ±5 °C after self-alignment ±1 %
Invert signal	maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity	decimation yes f ±5 °C after self-alignment
Invert signal	<pre>maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity ≤ 5 mV/div to ≥ 1 mV/div</pre>	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 %
Invert signal DC gain accuracy	maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 %
Invert signal DC gain accuracy Input coupling	maximum operating temperature change of input sensitivity > 5 mV/div input sensitivity ≤ 5 mV/div to ≥ 1 mV/div input sensitivity < 1 mV/div	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND
Invert signal DC gain accuracy	maximum operating temperature change of input sensitivity > 5 mV/div input sensitivity ≤ 5 mV/div to ≥ 1 mV/div input sensitivity < 1 mV/div	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div
Invert signal DC gain accuracy Input coupling Input sensitivity	$\begin{array}{l} \mbox{maximum operating temperature change o}\\ \mbox{input sensitivity} > 5 mV/div\\ \mbox{input sensitivity}\\ \le 5 mV/div to \ge 1 mV/div\\ \mbox{input sensitivity} < 1 mV/div\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega \end{array}$	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div 0.5 mV/div to 10 V/div
Invert signal DC gain accuracy Input coupling	$\begin{array}{c} \mbox{maximum operating temperature change o}\\ \mbox{input sensitivity} > 5 mV/div\\ \mbox{input sensitivity}\\ \le 5 mV/div to \ge 1 mV/div\\ \mbox{input sensitivity} < 1 mV/div\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 50 }\Omega\\ \end{array}$	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div 0.5 mV/div to 10 V/div 5 V (RMS), max. 30 V (V _P)
Invert signal DC gain accuracy Input coupling Input sensitivity	$\begin{array}{l} \mbox{maximum operating temperature change o}\\ \mbox{input sensitivity} > 5 mV/div\\ \mbox{input sensitivity}\\ \le 5 mV/div to \ge 1 mV/div\\ \mbox{input sensitivity} < 1 mV/div\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega \end{array}$	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div 0.5 mV/div to 10 V/div 5 V (RMS), max. 30 V (V _p) 300 V (RMS), 400 V (V _p), derates at
Invert signal DC gain accuracy Input coupling Input sensitivity	$\begin{array}{c} \mbox{maximum operating temperature change o}\\ \mbox{input sensitivity} > 5 mV/div\\ \mbox{input sensitivity}\\ \le 5 mV/div to \ge 1 mV/div\\ \mbox{input sensitivity} < 1 mV/div\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 50 }\Omega\\ \end{array}$	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div 0.5 mV/div to 10 V/div 5 V (RMS), max. 30 V (V _p) 300 V (RMS), 400 V (V _p), derates at 20 dB/decade to 5 V (RMS) above
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage	$\begin{array}{c} \mbox{maximum operating temperature change o}\\ \mbox{input sensitivity} > 5 mV/div\\ \mbox{input sensitivity}\\ \le 5 mV/div to \ge 1 mV/div\\ \mbox{input sensitivity} < 1 mV/div\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 50 }\Omega\\ \end{array}$	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div 0.5 mV/div to 10 V/div 5 V (RMS), max. 30 V (V _p) 300 V (RMS), 400 V (V _p), derates at 20 dB/decade to 5 V (RMS) above 250 kHz
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range	maximum operating temperature change oinput sensitivity > 5 mV/divinput sensitivity \leq 5 mV/div to \geq 1 mV/divinput sensitivity < 1 mV/div	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div 0.5 mV/div to 10 V/div 5 V (RMS), max. 30 V (V _p) 300 V (RMS), 400 V (V _p), derates at 20 dB/decade to 5 V (RMS) above
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage	maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity \leq 5 mV/div to \geq 1 mV/div input sensitivity < 1 mV/div	decimation yes f ±5 °C after self-alignment ±1 % ±1.5 % ±2.5 % DC, AC, GND 0.5 mV/div to 1 V/div 0.5 mV/div to 10 V/div 5 V (RMS), max. 30 V (V _p) 300 V (RMS), 400 V (V _p), derates at 20 dB/decade to 5 V (RMS) above 250 kHz ±5 div
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range	maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity ≤ 5 mV/div to ≥ 1 mV/div input sensitivity < 1 mV/div	decimationyes $\pm 5 ^{\circ}C$ after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND0.5 mV/div to 1 V/div0.5 mV/div to 10 V/div5 V (RMS), max. 30 V (V _p)300 V (RMS), 400 V (V _p), derates at20 dB/decade to 5 V (RMS) above250 kHz ± 5 div
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range	$\begin{array}{c} \mbox{maximum operating temperature change o}\\ \mbox{input sensitivity} > 5 mV/div\\ \mbox{input sensitivity}\\ \le 5 mV/div to \ge 1 mV/div\\ \mbox{input sensitivity} < 1 mV/div\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 3.0 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 3.3 }mV/div to 1 V/div\\ \mbox{a 3.8 }mV/div to 111 mV/div\\ \end{tabular}$	decimationyes $\pm 5 ^{\circ}C$ after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND0.5 mV/div to 1 V/div0.5 mV/div to 10 V/div5 V (RMS), max. 30 V (V _p)300 V (RMS), 400 V (V _p), derates at20 dB/decade to 5 V (RMS) above250 kHz ± 5 div $\pm (30 V - 5 div \times input sensitivity)$ $\pm (10 V - 5 div \times input sensitivity)$
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range Offset range at 50 Ω	$\begin{array}{c} \mbox{maximum operating temperature change o}\\ \mbox{input sensitivity} > 5 mV/div\\ \mbox{input sensitivity}\\ \le 5 mV/div to \ge 1 mV/div\\ \mbox{input sensitivity} < 1 mV/div\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 50 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 3.0 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 0 }\Omega\\ \mbox{at 0 }\Omega\\ \mbox{at 1 }M\Omega\\ \mbox{at 0 }\Omega\\ \mbox{at 0 }$	decimationyes $\pm 5 ^{\circ}C$ after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND0.5 mV/div to 1 V/div0.5 mV/div to 10 V/div5 V (RMS), max. 30 V (V _p)300 V (RMS), 400 V (V _p), derates at20 dB/decade to 5 V (RMS) above250 kHz ± 5 div
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range	maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity \leq 5 mV/div to \geq 1 mV/div input sensitivity < 1 mV/divat 50 Ω at 1 M Ω at 50 Ω at 1 M Ω at 1 M Ω at 30 Ω at 1 M Ω at 50 Ω at 1 M Ω input sensitivity \geq 112 mV/div to 1 V/div \geq 33.8 mV/div to 111 mV/div 0.5 mV/div to 33.6 mV/div input sensitivity	decimationyes $\pm 5 ^{\circ}C$ after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND $0.5 $ mV/div to 1 V/div $0.5 $ mV/div to 10 V/div $5 $ V (RMS), max. 30 V (V _p) $300 $ V (RMS), 400 V (V _p), derates at $20 $ dB/decade to 5 V (RMS) above $250 $ kHz $\pm 5 $ div $\pm (30 $ V - 5 div × input sensitivity) $\pm (10 $ V - 5 div × input sensitivity) $\pm (2 $ V - 5 div × input sensitivity)
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range Offset range at 50 Ω	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	decimationyes $f \pm 5 ^{\circ}$ C after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND0.5 mV/div to 1 V/div0.5 mV/div to 10 V/div5 V (RMS), max. 30 V (V _P)300 V (RMS), 400 V (V _p), derates at20 dB/decade to 5 V (RMS) above250 kHz ± 5 div $\pm (30 ^{\circ}V - 5 ^{\circ}div \times input sensitivity)$ $\pm (2 ^{\circ}V - 5 ^{\circ}div \times input sensitivity)$ $\pm (250 ^{\circ}V - 5 ^{\circ}div \times input sensitivity)$
Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range Offset range at 50 Ω	$\begin{tabular}{ c c c c } \hline maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity $$ 5 mV/div to $$ 1 mV/div input sensitivity < 1 mV/div $$ at 50 Ω at 1 MΩ at 50 Ω at 1 MΩ at 50 Ω at 1 MΩ at 1 MΩ at 1 MΩ at 1 MΩ at 50 Ω mV/div to 10 V/div$ at 515 mV/div to 510 mV/div$ at 50.5 mV/div to 510 mV/div$ at 510 mV/div$ a$	decimationyes $\pm 5 ^{\circ}C$ after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND0.5 mV/div to 1 V/div0.5 mV/div to 10 V/div5 V (RMS), max. 30 V (V _p)300 V (RMS), 400 V (V _p), derates at20 dB/decade to 5 V (RMS) above250 kHz $\pm 5 ^{\circ}$ div $\pm (30 ^{\circ}V - 5 ^{\circ}$ div × input sensitivity) $\pm (2 ^{\circ}V - 5 ^{\circ}$ div × input sensitivity) $\pm (250 ^{\circ}V - 5 ^{\circ}V \times input sensitivity)$ $\pm (250 ^{\circ}V - 5 ^{\circ}V \times input sensitivity)$
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Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range Offset range at 50 Ω Offset range at 1 MΩ Offset accuracy	maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity \leq 5 mV/div to \geq 1 mV/div input sensitivity < 1 mV/divat 50 Ω at 1 M Ω at 50 Ω at 1 M Ω at 1 M Ω at 30 Ω at 1 M Ω input sensitivity \geq 112 mV/div to 1 V/div \geq 33.8 mV/div to 111 mV/div 0.5 mV/div to 33.6 mV/divinput sensitivity \geq 515 mV/div to 510 mV/div 0.5 mV/div to 50 mV/divafter adequate suppression of	decimationyes $\pm 5 ^{\circ}C$ after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND $0.5 $ mV/div to 1 V/div $0.5 $ mV/div to 10 V/div $5 $ V (RMS), max. 30 V (V _p) $300 $ V (RMS), 400 V (V _p), derates at $20 $ dB/decade to 5 V (RMS) above $250 $ kHz $\pm 5 $ div $\pm (30 $ V - 5 div × input sensitivity) $\pm (20 $ V - 5 div × input sensitivity) $\pm (250 $ V - 5 div × input sensitivity) $\pm (250 $ V - 5 div × input sensitivity) $\pm (250 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (0.5 $ % × offset +0.1 div × input sensitivity + 0.5 mV) $\pm (DC $ gain accuracy × reading - net
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Invert signal DC gain accuracy Input coupling Input sensitivity Maximum input voltage Position range Offset range at 50 Ω Offset range at 1 MΩ Offset accuracy	maximum operating temperature change o input sensitivity > 5 mV/div input sensitivity \leq 5 mV/div to \geq 1 mV/div input sensitivity < 1 mV/divat 50 Ω at 1 M Ω at 50 Ω at 1 M Ω at 1 M Ω at 30 Ω at 1 M Ω at 50 Ω at 1 M Ω after adequate suppression of measurement noise by using either high-	decimationyes $\pm 5 ^{\circ}C$ after self-alignment $\pm 1 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 1.5 ^{\circ}$ $\pm 2.5 ^{\circ}$ DC, AC, GND $0.5 $ mV/div to 1 V/div $0.5 $ mV/div to 10 V/div $5 $ V (RMS), max. 30 V (V _p) $300 $ V (RMS), 400 V (V _p), derates at $20 $ dB/decade to 5 V (RMS) above $250 $ kHz $\pm 5 $ div $\pm (30 $ V - 5 div × input sensitivity) $\pm (20 $ V - 5 div × input sensitivity) $\pm (250 $ V - 5 div × input sensitivity) $\pm (250 $ V - 5 div × input sensitivity) $\pm (250 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (25 $ V - 5 div × input sensitivity) $\pm (0.5 $ % × offset +0.1 div × input sensitivity + 0.5 mV) $\pm (DC $ gain accuracy × reading - net

RMS noise floor at 1 MΩ (meas.)	Input sensitivity	R&S®			
		RTA4004	RTA4004 with -B243 option	RTA4004 with -B245 option	RTA4004 with -B2410 option
	10 V/div	271 mV	300 mV	370 mV	370 mV
	5 V/div	161 mV	172 mV	230 mV	230 mV
	2 V/div	64 mV	70 mV	100 mV	100 mV
	1 V/div	38 mV	43 mV	60 mV	60 mV
	500 mV/div	16 mV	17 mV	23 mV	23 mV
	200 mV/div	6 mV	7 mV	10 mV	10 mV
	100 mV/div	3.6 mV	4.1 mV	5.80 mV	5.80 mV
	50 mV/div	1.6 mV	1.6 mV	2.10 mV	2.10 mV
	20 mV/div	0.7 mV	0.8 mV	1.10 mV	1.10 mV
	10 mV/div	0.4 mV	0.4 mV	0.60 mV	0.60 mV
	5 mV/div	0.21 mV	0.25 mV	0.33 mV	0.33 mV
	2 mV/div	0.14 mV	0.18 mV	0.24 mV	0.24 mV
	1 mV/div	0.13 mV	0.14 mV	0.18 mV	0.18 mV
	0.5 mV/div	0.12 mV	0.13 mV	0.17 mV	0.17 mV
RMS noise floor at 50 Ω (meas.)	Input sensitivity	R&S®			
		RTA4004	RTA4004 with	RTA4004 with	RTA4004 with
			-B243 option	-B245 option	-B2410 option
	1 V/div	27 mV	27 mV	30 mV	38.0 mV
	500 mV/div	15 mV	16 mV	18 mV	24.0 mV
	200 mV/div	8 mV	9 mV	10 mV	13.0 mV
	100 mV/div	3.2 mV	3.6 mV	4.1 mV	5.50 mV
	50 mV/div	1.7 mV	1.9 mV	2.2 mV	2.90 mV
	20 mV/div	0.7 mV	0.8 mV	0.8 mV	1.10 mV
	10 mV/div	0.3 mV	0.3 mV	0.4 mV	0.50 mV
	5 mV/div	0.18 mV	0.22 mV	0.24 mV	0.33 mV
	2 mV/div	0.08 mV	0.11 mV	0.12 mV	0.16 mV
	1 mV/div	0.08 mV	0.09 mV	0.1 mV	0.14 mV
	0.5 mV/div	0.06 mV	0.08 mV	0.1 mV	0.13 mV

Horizontal system

Timebase range		selectable between
		0.5 ns/div and 500 s/div
Channel deskew		±500 ns
Trigger offset range	minimum	memory depth
		actual sampling rate
	maximum	2 ³³
		actual sampling rate
Modes		normal, roll
Channel-to-channel skew		< 200 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±0.5 ppm
	during calibration interval	±1.5 ppm
Delta time accuracy	corresponds to time error between to edges on same acquisition and channel; waveform sample rate Fs can be obtained via SCPI command "ACQ:SRAT?"; signal amplitude greater than 5 divisions, measurement threshold set to 50 %, vertical gain 10 mV/div or greater; rise time lower than 4/Fs; waveform acquired in sample mode	±(1.34/Fs + timebase accuracy × reading) (peak) (meas.)

Acquisition system

Maximum realtime sampling rate	normal mode	2.5 Gsample/s
	interleaved mode,	5 Gsample/s
	if following channels are not used	
	simultaneously:	
	 channel 1 and channel 2 	
	 channel 3 and channel 4 	
	logic channels	
Memory depth per channel	normal mode	100 Msample per channel
	interleaved mode,	200 Msample per channel
	if following channels are not used	
	simultaneously:	
	 channel 1 and channel 2 	
	 channel 3 and channel 4 	
	logic channels	
Acquisition modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation interval (400 ps detection)
	high resolution	average value of all samples in decimation interval
	envelope	envelope of acquired waveforms
	average	average over a series of acquired waveforms
	envelope + peak detect	envelope of acquired waveforms with active peak detect
	envelope + high resolution	envelope of acquired waveforms with active high resolution
	average + high resolution	average over a series of acquired high resolution waveforms
Number of averaged waveforms		2 to 100 000
Waveform acquisition rate	dot display, single channel, auto record length	up to 64 000 waveforms/s

Trigger system

Trigger level	range	±5 div from center of screen
Trigger modes		auto, normal, single, n single
Hold-off range	time	inactive or 51.2 ns to 13.7 s
Trigger types		edge, width, video, pattern, runt, rise time, fall time, serial bus, line, timeout
	actions on trigger	pulse, sound, screenshot, save waveform, save reference waveform
Edge trigger A	trigger events	rising edge, falling edge, both edges
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S [®] RTA-B1 option), external trigger input
	trigger coupling	DC, AC (attenuates < 10 Hz (meas.)), LF reject (attenuates < 10 kHz (meas.))
	trigger filter	HF reject (attenuates > 100 kHz (meas.)), noise reject (attenuates > 100 MHz (meas.))
	selectable trigger hysteresis	automatic, small, medium, large

Trigger A sensitivity hysteresis mode	with DC, AC, LF reject, noise reject	
automatic	1 GHz, 500 MHz, 350 MHz	$2.2 mV_{pp}$
		$> \frac{2.2 mV_{pp}}{input sensitivity} + 1 div (nom.)$ (input sensitivity: [mV/div])
	200 MHz, 100 MHz	$> \frac{1.5 mV_{pp}}{input sensitivity} + 0.8 div (nom.)$
		(input sensitivity: [mV/div])
	20 MHz	$> \frac{0.6 mV_{pp}}{input sensitivity} + 0.4 div (nom.)$ (input sensitivity: [mV/div])
	with HF reject	
	all input sensitivities	1 div (meas.)
Edge trigger A and B	trigger events	rising edge, falling edge, both edges
	sources for A trigger	Haing edge, failing edge, beth edges
	R&S®RTA4004	channel 1 channel 2 channel 3
	K&S ⁻ KTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)
	trigger coupling of A trigger	DC
	sources for B trigger	·
	R&S®RTA4004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0 (with R&S [®] RTA-B1 option)
	trigger coupling of B trigger	DC
	selectable trigger hysteresis for A and B trigger	small, medium, large
	trigger B mode	after time or after events
	trigger B minimum time	3.2 ns
	trigger B maximum time	100 s
	trigger B events	1 to 65535
Width trigger		
Width trigger	trigger events	pulse width is smaller, greater, equal, unequal, inside interval, outside interval
	minimum pulse width	3.2 ns
	maximum pulse width	6.8 s
	polarity	positive, negative
	sources	
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0
		(with R&S [®] RTA-B1 option)
	selectable trigger hysteresis	small, medium, large
Timeout trigger	trigger events	greater than timeout
	minimum timeout	3.2 ns
	maximum timeout	6.8 s
	polarity	stays high, stays low
	sources	
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0
		(with R&S [®] RTA-B1 option)
	selectable trigger hysteresis	small, medium, large
Video trigger	trigger events	selectable line, all lines, even frame, odd frame, all frames
	supported standards	PAL, NTSC, SECAM, PAL-M, SDTV 576i HDTV 720p, HDTV 1080i, HDTV 1080p
	sources	
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, ext. trigger input

Pattern trigger	trigger events	logic condition between active channels		
	sources			
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S [®] RTA-B1 option)		
	state of channels	high, low, don't care		
	logic between channels	and/or		
	condition	true, false		
	duration condition	smaller, greater, equal, unequal, inside interval, outside interval, timeout		
	minimum duration time	3.2 ns		
	maximum duration time	6.8 s		
Runt trigger		triggers on pulse of positive, negative or either polarity that crosses one threshold but fails to cross a second threshold before crossing the first one again		
Rise time, fall time	trigger events	time between the crossing of two selectable levels is smaller, greater, equal, unequal, inside interval, outside interval		
	minimum rise time	3.2 ns		
	maximum rise time	6.8 s		
	polarity	rising edge, falling edge, both edges		
	sources			
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4		
Serial bus trigger	supported standards			
	R&S [®] RTA-K1 option	I ² C, SSPI (two-wire, MOSI/MISO), SPI (three-wire, MOSI/MISO)		
	R&S [®] RTA-K2 option	UART/RS-232/RS-422/RS-485 (RX/TX)		
	R&S [®] RTA-K3 option	CAN/LIN		
	R&S [®] RTA-K5 option	audio (I ² S, LJ, RJ, TDM)		
	R&S [®] RTA-K6 option	MIL-STD-1553		
	R&S [®] RTA-K7 option	ARINC 429		
External trigger input	input impedance	1 M Ω ± 1 % with 14 pF ± 2 pF (meas.)		
	maximum input voltage at 1 M Ω	300 V (RMS), 400 V (V _p), derates at 20 dB/decade to 5 V (RMS) above 250 kHz		
	trigger level	±5 V		
	sensitivity	> 300 mV (V _{pp})		
	coupling	DC, AC, LF reject		
Trigger output	functionality	A pulse is generated for every acquisition trigger event.		
	output voltage			
	at high impedance	0 V to 4.8 V		
	at 50 Ω	0 V to 2.4 V		
	pulse polarity	high active		

Waveform measurements

Automatic measurements	measurements on channels, math waveforms, reference waveforms	burst width, count positive pulses, count negative pulses, count falling edges, count rising edges, mean value, RMS cycle, RMS, mean cycle, peak peak, peak+, peak-, frequency, period, amplitude, top level, base level, positive overshoot, negative overshoot, pulse width+, pulse width-, duty cycle+, duty cycle-, rise time, fall time, delay, phase, crest factor, slew rate+, slew rate-, σ.std. deviation, σ.std. deviation cycle, delay to trigger	
	reference levels	lower, middle and upper level in percentage	
	statistics	maximum, minimum, mean, standard deviation and measurement count for each automatic measurement	
	number of active measurements	8	
Cursor measurements	type	vertical, horizontal, vertical and horizontal, V-marker	
	functions	x and y tracking, coupling of cursors, set to trace, two sources selectable	
Quick measurements	function	fast overview of measurements from one channel, some measurements displayed with result lines in diagram	
	sources		
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4	
	measurements displayed in diagram	mean, max. peak, min. peak, rise time, fall time	
	numerically displayed measurements	RMS cycle, peak-to-peak voltage, period, frequency	

Digital voltmeter

Accuracy		related to channel settings of voltmeter
		source
Measurements		DC, AC+DC RMS, AC RMS
Sources	R&S [®] RTA4004	channel 1, channel 2, channel 3,
		channel 4
Number of measurements		up to 4
Resolution		up to 3 digits
Bandwidth		1 MHz

Counter

Measurements		frequency, period
Sources	R&S [®] RTA4004	channel 1, channel 2, channel 3,
		channel 4, trigger signal source
Number of measurements		2
Resolution		7 digits
Frequency range		0.05 Hz to bandwidth of oscilloscope
		(limited by bandwidth of trigger filter)

Mask testing

Sources	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4
Mask definition		acquired waveform with user-defined tolerance, can be stored and restored
Result statistics		completed acquisitions, passed and failed acquisitions (absolute and in percent), test duration
Actions on mask violation		sound, acquisition stop, screenshot, save waveform, pulse out (AUX OUT connector)
Captured segments		all segments, failed segments

Waveform maths

Number of math equations		up to 5
Functions		addition, subtraction, multiplication,
		division, square, square root, absolute
		value, reciprocal, inverse, log10, ln,
		derivation, integration, low pass, high
		pass, track period, track frequency, track
		pulse width, track duty cycle
	R&S [®] RTA4004	channel 1, channel 2, channel 3,
		channel 4, math waveforms 1 to 4

Fast Fourier transform (FFT)

Sources	R&S [®] RTA4004	channel 1, channel 2, channel 3,
		channel 4, math waveforms, references
Setup parameters		start frequency, stop frequency, center
		frequency, frequency span, vertical scale,
		vertical position, resolution bandwidth,
		gate (time range and position)
Windows		Hanning, Hamming, Blackman,
		rectangular, flat top
Waveform arithmetic		none, min. hold, max. hold, average
		(selectable 2 to 1024)
Scaling		dBm, dBV, dBµV, V (RMS)

Search function

Functions	search types	edge, width, peak, rise/fall time, runt,
		data2clock, pattern, window, protocol
		(available with R&S [®] RTA-K3,
		R&S [®] RTA-K6 and R&S [®] RTA-K7 options)
	configuration	manual level setting on screen, level with
		selectable hysteresis
	display of search events	up to 10 000 events in diagram and in
		result table
	markers on search events	up to 32 markers
	navigation in search events (stop mode)	knob (if result table is active)
Sources	R&S [®] RTA4004	channel 1, channel 2, channel 3,
		channel 4, math waveforms from 1 to 5,
		D15 to D0 (with R&S [®] RTA-B1 option)

Display characteristics

Diagram types	manually changeable vertical window size	Yt, XY, zoom, FFT, spectrogram (with R&S [®] RTA-K37 option)
XY mode		parallel display of XY diagram and Yt diagrams of input signals for X, Y
Zoom		horizontal and vertical zoom, split screen with overview signal and zoomed signal
Interpolation		sin(x)/x, linear, sample & hold
FFT mode		split screen with Yt diagrams and
		dedicated frequency diagram,
		spectrogram (with R&S®RTA-K37 option)
Waveform display		lines, dots only
Persistence		50 ms to 12.8 s; infinite
Special display mode		inverse brightness, waveform color modes
		for analog channels (temperature, fire, rainbow)
Diagram grid		lines, reticle, none, with annotation, track
		grid
Reference signals		up to 4 reference signals

Protocol and logic

Bus decode	number of bus signals	4 ¹
	bus types	parallel, parallel clocked
	R&S [®] RTA-K1 option	SSPI, SPI, I ² C
	R&S [®] RTA-K2 option	UART/RS-232/RS-422/RS-485
	R&S [®] RTA-K3 option	CAN, LIN
	R&S [®] RTA-K5 option	I ² S, LJ, RJ, TDM
	R&S [®] RTA-K6 option	MIL-STD-1553
	R&S [®] RTA-K7 option	ARINC 429
	display types	decoded bus, logical signal,
		frame table (depends on decoded bus)
	position and size	size and position on screen selectable
	data format of decoded bus	hex, decimal, binary, octal, ASCII

History and segmented memory

Acquisition memory		automatic, predef	ined, manual		
	automatic	automatic segme	nt size and numbers	6	
	predefined	defined size and automatic numbers			
	manual	user-defined size	user-defined size and numbers		
Memory segmentation	function	memory segments for the acquisition			
	number of segments ²	record length	segments	total memory	
	_	_	(up to)	(per channel)	
		5 ksample	87 380	436.9 Msample	
		10 ksample	87 380	873.8 Msample	
		20 ksample	43 690	873.8 Msample	
		50 ksample	17 476	873.8 Msample	
		100 ksample	9 708	970.8 Msample	
	-	200 ksample	5 140	1028 Msample	
		500 ksample	2 131	1065.5 Msample	
		1 Msample	1 065	1065 Msample	
		2 Msample	536	1072 Msample	
		5 Msample	214	1070 Msample	
		10 Msample	107	1070 Msample	
		20 Msample	53	1060 Msample	
		50 Msample	21	1050 Msample	
		100 Msample	10	1000 Msample	
		200 Msample	5	1000 Msample	
	Segmentation is active spectrum analysis.	on all analog and lo	ogic channels, proto	col decoding and	

¹ If a bidirectional bus is used (e.g. UART RX/TX or SPI MOSI/MISO), two bus decoders are occupied.

² At interleaved mode.

Fast-segmented mode		continuous recording of waveforms in acquisition memory without interruption due to visualization; blind time between consecutive acquisitions less than 200 ns (up to 2 000 000 waveforms/s)	
History mode	function	The history mode always provides access to past acquisitions in the segmented memory.	
	timestamp resolution	3.2 ns	
	history player	replays the recorded waveforms; repetition possible; adjustable speed; manual next/previous segment; numerical segment number input	
	analyze options	overlay all segments, average all segments, envelope all segments	

Miscellaneous

Save/recall	device settings	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
	reference waveforms	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
	waveforms	save on USB memory stick or download and save on a PC via web interface or USB-MTP, available file formats: BIN, CSV, TXT float (MSB/LSB first)
	screenshots	save on USB memory stick or download and save on a PC via web interface or USB-MTP, available file formats: BMP, PNG
	device settings	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
Camera key		configurable camera key, actions on press:save screenshot
		one-touch
	save screenshot	one-touch off
	one-touch	one or more from the list: • setup
		 screenshots (PNG, color) waveforms (BIN-MSB, CI, display data) references
		search event tablebus tablestatistics
Instrument security		secure erasure of internal file system and all settings
Menu languages		available menu languages: English German
		FrenchSpanish
		ItalianPortuguese
		CzechPolish
		Russian
		Simplified Chinese
		Traditional ChineseKorean
		KoreanJapanese
Help		online help, available languages: English
Undo/Redo		deep Undo/Redo function

Input and outputs

Front		
Channel inputs		BNC, for details see Vertical system
	probe interface	auto detection of passive probes,
		Rohde & Schwarz active probe interface
External trigger input		BNC, for details see Trigger system
	probe interface	auto detection of passive probes
Waveform generator		BNC, for details see R&S [®] RTA-B6,
(requires R&S®RTA-B6 option)		waveform generator,
		demo lug and GND lug
Probe compensation output	signal shape	rectangle
	frequency	1 kHz
	voltage	$V_{low} = 0 V, V_{high} = 1.5 V to 3.3 V (meas.)$
Pattern source	P3 to P0	4 lugs, for details see R&S [®] RTA-B6,
(requires R&S [®] RTA-B6 option)		4-bit pattern generator
	frequency	1 mHz to 25 MHz
	voltage	$V_{low} = 0 V, V_{high} = 1.5 V to 3.3 V (meas.)$
Ground lug		connected to ground
USB host interface		1 port, type A plug, version 2.0,
		flash drives only
Rear		
Ethernet interface		1 port, 1 Gbit
AUX OUT (BNC)	trigger out,	for details see Trigger system
	reference frequency	10 MHz ±3.5 ppm (meas.)
	mask violation	pulse
USB device interface		1 port, type B plug, version 2.0
Fixation loop		for securing the instrument with a cable
Security slot		for standard Kensington style lock
Right side		
Digital channel inputs	D15 to D8, D7 to D0	requires R&S [®] RTA-B1 option

General data

Display		
Туре		10.1" WXGA display with capacitive touch
Resolution		1280 × 800 pixel (WXGA)
Temperature		
Temperature loading	operating temperature range	0 °C to +50 °C
	storage temperature range	–40 °C to +70 °C
Climatic loading		+25 °C/+40 °C at 85 % rel. humidity cyclic,
		in line with IEC 60068-2-30
Altitude		
Operating		up to 3000 m above sea level
Nonoperating		up to 4600 m above sea level
Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 1.8 g at 55 Hz;
		0.5 g from 55 Hz to 150 Hz,
		in line with EN 60068-2-6
		MIL-PRF-28800F, 4.5.5.3.2 sinusoidal
		vibration, class 3 and 4
	random	10 Hz to 300 Hz,
		acceleration 1.2 g (RMS), in line with EN 60068-2-64,
		MIL-PRF-28800F, 4.5.5.3.1 random
		vibration, class 3 and 4
Shock		40 g shock spectrum,
SHOCK		in line with MIL-STD-810E,
		method no. 516.4, procedure I,
		MIL-PRF-28800F, 4.5.5.4.1 functional
		shock, 30 g, 11 ms, halfsine
EMC		
RF emission		in line with CISPR 11/EN 55011 group 1
		class A (for a shielded test setup);
		the instrument complies with the emission
		requirements stipulated by EN 55011,
		EN 61326-1 and EN 61326-2-1 class A,
		making the instrument suitable for use in
		industrial environments
Immunity		in line with IEC/EN 61326-1 table 2,
		immunity test requirements for industrial
		environments ³
Certifications		VDE, _C CSA _{US} , KC
Calibration interval		1 year
Power supply		
AC supply		100 V to 240 V at 50 Hz to 60 Hz,
		1.6 A to 0.7 A
Power consumption		max. 160 W
Safety		in line with
		• IEC 61010-1, IEC 61010-2-030
		• EN 61010-1, EN 61010-2-030
		CAN/CSA-C22.2 No. 61010-1
		• CAN/CSA-C22.2 No. 61010-2-030
Machaniaal data		• UL 61010-1, UL 61010-2-030
Mechanical data	Weller	200 mm - 200 mm - 450 mm
Dimensions	W×H×D	390 mm × 220 mm × 152 mm (15.25 in x 8.66 in x 5.09 in)
Woight	without options (new)	(15.35 in × 8.66 in × 5.98 in)
Weight	without options (nom.)	3.3 kg (7.275 lb)
Audible noise	maximum sound pressure level at a	28.3 dB(A)
	distance of 1.0 m	

 $^{^3}$ $\,$ Test criterion is displayed noise level within ±1 div for input sensitivity of 5 mV/div.

Options

Mixed signal option, additional 16 log Vertical system			
Input channels		16 logic channels (from D15 to D0)	
Arrangement of input channels		arranged in two logic probes with 8 channels each, assignment of the logic probes to the channels D15 to D8 and D7 to D0	
Input impedance		100 kΩ ± 2 % ~4 pF (meas.) at probe tips	
Maximum input frequency	signal with minimum input voltage swing and hysteresis setting: normal	400 MHz (meas.)	
Maximum input voltage	· · ·	±40 V (V _p)	
Minimum input voltage swing		500 mV (V _{pp}) (meas.)	
Threshold groups		from D15 to D12, D11 to D8, D7 to D4 and D3 to D0	
Threshold level	user range	±8 V in 25 mV steps	
	predefined	CMOS 2.5 V, TTL 1.4 V, ECL -1.3 V	
Threshold accuracy	threshold setting between ± 4 V	±(100 mV + 3 % of threshold setting)	
Comparator hysteresis		small, medium, large	
Horizontal system			
Channel deskew	range for each channel	±500 ns	
Channel-to-channel skew		< 200 ps (meas.) for same vertical setting on the channels	
Acquisition system			
Sampling rate	two logic probes	2.5 Gsample/s on each channel	
	one logic probe	5 Gsample/s on each channel	
Memory depth	two logic probes	100 Msample for every channel	
	one logic probe	200 Msample for every channel	
Trigger system		see chapter Trigger system of the base unit	
Waveform measurements			
Measurement sources		all channels from D15 to D0	
Automatic measurements		positive pulse width, negative pulse width, period, frequency, burst width, delay, phase, positive duty cycle, negative duty cycle, positive pulse count, negative pulse count, rising edge count, falling edge count	
Additional cursor function		display of hex. value at the cursor position	
Display characteristics			
Channel activity display		independent of the oscilloscope acquisition, the state (stays low, stays high or toggles) of the channels from D15 to D0 is displayed	

Resolution		14 bit		
Sample rate		250 Msample/s		
Output impedance		$50 \Omega \pm 1 \%$ (meas.)		
Amplitude	lovel	50 12 ±1 % (meas.)		
Amplitude	level	20 m/(10 10)/(1/1)		
	in to high Z in to 50 Ω	$20 \text{ mV to } 10 \text{ V (V_{pp})}$		
		10 mV to 5 V (V _{pp}) 1.5 %		
DC offset	accuracy (frequency ≤100 kHz)	1.5 %		
DC offset	level in to high Z	± 5 V		
	in to 50 Ω	± 5 V ± 2.5 V		
		1.5 % or ±3 mV whatever is greater		
Sine	accuracy	0.1 Hz to 25 MHz		
Sine	frequency			
	SFDR	> 40 dBc (meas.)		
Destas als	THD	> 40 dBc (meas.)		
Rectangle	frequency	0.1 Hz to 10 MHz		
Pulse	frequency	0.1 Hz to 10 MHz		
	edge time	adjustable		
	duty cycle	1 % to 99 %		
Ramp, triangle, sinc, exponential	frequency	0.1 Hz to 1 MHz		
Arbitrary	sample rate	max. 10 Msample/s		
Al-'	memory depth	32k point		
Noise	bandwidth	max. 25 MHz		
	level	0 to 100 % of signal amplitude		
Modulation	AM			
	function	sine, rectangle, triangle, ramp		
	frequency	0.1 Hz to 1 MHz		
	depth	0 to 100 %		
	FM			
	function	sine, rectangle, triangle, ramp		
	frequency	0.1 Hz to 1 MHz		
	deviation	depends on modulation frequency		
	ASK			
	function	sine, rectangle, triangle, ramp		
	frequency	0.1 Hz to 1 MHz		
	ASK depth	0 to 100 %		
	FSK			
	function	sine, rectangle, triangle, ramp		
	frequency	0.1 Hz to 1 MHz		
	FSK rate	0.1 Hz to carrier frequency/2		
Sweep	start frequency	1 Hz to 25 MHz		
	stop frequency	1 Hz to 25 MHz		
	sweep time	1 ms to 10 s		
	sweep type	linear, logarithmic, triangle		
Burst	number of cycle	1 to 1024		
	idle time	28 ns to 17 s		
	start phase	0° to 360°		
	trigger	continuous, manually		
4-bit pattern generator		· · · · · ·		
Functions		probe adjust/square wave, bus signal		
		source 4-bit counter, programmable 4-b		
		pattern		
Bus signal source		SPI, I ² C, UART, CAN, LIN, audio, PWM		
~	bandwidth	9600 bit/s to 1 Mbit/s		
4-bit counter	frequency	25 mHz to 50 MHz		
Programmable pattern	sample rate	20 ns to 1 s, up/down		
- J	square wave frequency	1 mHz to 500 kHz		
	memory depth	8096 bit per channel		
	pattern idle time	50 ns to 1 s		
	amplitude	$V_{low} = 0 V, V_{high} = 1.5 V to 3.3 V (meas.)$		

I ² C triggering and decoding			
Bus configuration	sources for SCL and SDA		
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)	
	bit rate	up to 10 Mbps	
	size of address	7 bit or 10 bit	
	size of data	8 bit	
	label list	associate frame identifier with symbolic ID	
Trigger	trigger events	start, stop, restart, missing acknowledge, address (7 bit or 10 bit), data, address and data	
	offset for trigger on data	0 data byte to 4095 data byte	
	data pattern width	up to 3 sequential data byte	
Decode	displayed signals	bus signal, logic signal or both	
	color coding of bus signal	address, data, start, stop, ACK, NACK, error	
	displayed format of address	hex, symbolic ID (label list)	
	displayed format of data	ASCII, binary, decimal or hex	
SPI triggering and decoding			
Bus configuration	sources for CS, CLK, MOSI and MISC	0	
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S [®] RTA-B1 option)	
	bit rate	up to 25 Mbps	
	chip select (CS)	active low, active high or missing (SSPI)	
	clock (CLK) slope	rise or fall	
	data symbol size	1 bit to 32 bit	
	idle time for SSPI	12.8 ns to 26.8 ms	
Trigger	trigger events	start of frame, end of frame, bit number, data pattern	
	selectable bit number	0 to 4095	
	offset for trigger on data pattern	0 to 4095 bit	
	data pattern size	1 bit to 32 bit	
Decode	displayed signals	bus signal, logic signal or both	
	color coding of bus signal	data, start, stop, error	
	displayed format of data	ASCII, binary, decimal or hex	
	data decoding	MSB or LSB first	

Bus configuration	source for RX and TX		
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTA-B1 option)	
	bit rate	300 bps to 1 Mbps or user-selectable up to 6 Mbps	
	end of frame	timeout	
	signal polarity	idle low, idle high	
	data symbol size	5 bit to 9 bit	
	parity	none, even or odd	
	stop bits	1, 1.5 or 2	
	Idle time	up to 26.8 ms	
Trigger	trigger events	start bit, start of frame, symbol number, any symbol, pattern of symbols, parity error, stop bit error, break	
	offset for trigger on data symbol	0 to 4095 symbols	
	data symbol pattern width	1 to floor (32/symbol size) symbols	
Decode	displayed signals	bus signal, logic signal or both	
	color coding of bus signal	data, start, stop, error, parity	
	displayed format of data	ASCII, binary, decimal or hex	

CAN triggering and decoding		
Bus configuration	signal type	CAN_H, CAN_L
	bit rate	10/20/33.3/50/83.3/100/125/250/500/ 1000 kbps or user-selectable in range from 100 bps to 2 Mbps
	sampling point	10 % to 90 % within bit period
	label list	associate frame identifier with symbolic ID
Trigger	trigger events	start of frame, frame type, identifier,
		identifier + data, error condition (any
		combination of CRC error, bit stuffing
		error, form error and ACK error)
	identifier setup	frame type (data, remote or both),
		identifier type (11 bit or 29 bit);
		condition =, \neq , >, <; identifier selectable
		from label list
	data setup	data pattern up to 8 byte (hex or binary); condition =, \neq , >, <
Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	start of frame, identifier, DLC, data
		payload, CRC, ACK, end of frame, error frame, overload frame, CRC error, bit
		stuffing error, ACK error
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list
		errors highlighted in red; frame navigation data export as CSV file
Search	search events	frame, error, identifier, identifier + data, identifier + error
	frame event setup	start of frame, end of frame, overload
		frame, error frame, data ID 11 bit, data ID 29 bit, remote ID 11 bit, remote ID 29 bit
	error event setup	any combination of CRC error, bit stuffing error, form error and ACK error
	identifier setup	frame type (data, remote or both),
		identifier type (11 bit or 29 bit);
		condition =, \neq , >, <; identifier selectable
		from label list
	data setup	data pattern up to 8 byte (hex or binary); condition =, \neq , >, <
	event table	search results displayed as tabulated list; event navigation
LIN triggering and decoding		
Bus configuration	version	1.3, 2.x or SAE J2602; mixed traffic is supported
	bit rate	1.2/2.4/4.8/9.6/10.417/19.2 kbps or user-
		selectable in range from 100 bps to
		5 Mbps
	polarity	active high or active low
- .	label list	associate frame identifier with symbolic ID
Trigger	Source	
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0
	trigger events	(with R&S [®] RTA-B1 option) start of frame (sync break), identifier,
		identifier + data, wakeup frame, error
		condition (any combination of checksum
		error, parity error and sync field error)
	identifier setup	range from 0d to 63d; condition =, \neq , >, <;
		identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary);
		condition =, \neq , >, <

Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	frame, frame identifier, parity, data
		payload, checksum, error condition
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list,
		errors highlighted in red; frame navigation;
		data export as CSV file
Search	search events	frame, error, identifier, identifier + data,
		identifier + error
	frame event setup	start of frame, wake up
	error event setup	any combination of checksum error, parity
		error and sync field error
	identifier setup	range from 0d to 63d; condition =, \neq , >, <;
		identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary);
		condition =, ≠, >, <
	event table	search results displayed as tabulated list;
		event navigation

Audio (I ² S, LJ, RJ, TDM) trigg				
Bus configuration	source (data, clock, word/sync)			
	R&S [®] RTA4004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S [®] RTA-B1 option)		
	thresholds	per-channel threshold (analog channels), per-group threshold (logic channels), assisted threshold configuration (find level)		
	bit rate	up to 30 Mbps		
	signal type	I ² S standard, left justified, right justified, TDM		
	polarity	data: active high, active low; clock: rising edge, falling edge; word/sync: normal, inverted		
	word length	2 bit to 32 bit		
	bit order	most significant bit first (MSBF), least significant bit first (LSBF)		
	I ² S-specific setup			
	first channel	left, right		
	LJ/RJ-specific setup			
	first channel	left, right		
	channel offset	0 to 31 bit		
	TDM-specific setup			
	number of channels	1 to 8		
	channel length	2 bit to 32 bit		
	channel offset	0 to (channel length – word length) bits		
	channel delay	0 to 31 bit		
Trigger	trigger events	data, window, word/sync, error condition		
Tiggei	data setup	define individual value and condition for each audio channel; condition =, ≠, >, <, inside range, outside range, don't care; trigger when "all" or "any" audio channel conditions are met in single audio frame		
	window setup	audio channel setup same as data setup; user-defined window length up to 4 000 000 000 frames		
	word/sync setup	rising edge, falling edge		
Decode	displayed signals	bus signal, stacked bus signal, logic signal		
	color coding of bus signal	color-coded audio channels		
	displayed format of data	hex, signed decimal, binary, ASCII		
	frame table	decode results displayed as tabulated list with timestamp; frame navigation; data export as CSV file		
	track of audio waveform	displays audio channel content as a waveform that is time-correlated to the source signals; user can activate, scale and position each audio channel individually		

MIL-STD-1553 triggering and decoding	g	
Protocol configuration	source	
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4
	bit rate	standard bit rate (1 Mbit/s)
	polarity	normal, inverted
	label list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	max response (4 µs to 200 µs)
Trigger	trigger event setup	sync, word, command word, status word,
119901		command and data word, error condition
	sync setup	all words, command/status word, data
		word
	word setup	all words, command word, status word, data word
	command ward actum (type) address (ward)	
	command word setup (type: address/word)	RT address (condition =, \neq , \geq , \leq , in range, out of range); direction (T/R); subaddress (condition =, \neq , \geq , \leq , in range, out of
		range); data word count (condition =, \neq , \geq ,
		≤, in range, out of range)
	command word setup (type: mode code)	RT address (condition =, \neq , \geq , \leq , in range, out of range); subaddress (0, 31 or either);
		mode code from labeled dropdown list
	status word setup	RT address; status flags (message error,
		instrumentation, service request,
		broadcast command, busy, subsystem
		flag, dynamic bus control, terminal flag) individually configurable (1, 0, don't care)
	command and data word setup	transmission type (BC-RT, RT-BC, BC-
		BC, mode code); RT address (condition =, \neq , \geq , \leq , in range, out of range); subaddress
		(condition =, \neq , \ge , \le , in range, out of range); data word count (condition =, \neq , \ge , \le , in range, out of range); data pattern up
		to 4 words long (condition =, \neq , \geq , \leq , in range, out of range); payload data index
		(condition =)
	error condition setup	any combination of sync error, Manchester error, parity error, timing error (see
		protocol configuration)
Decode	display signals	bus signal; symbolic ID in bus signal when label list in use
	color coding	sync, RT address, subaddress, mode code, status bit field, data, error condition
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list,
		errors highlighted in red; frame navigation;
		data export as CSV file; column with
		symbolic ID when label list in use
Search	search events	word, command word, mode code, status
Jean	Search events	word, command and data word, error
	word setup	command, status, data
	command word setup	see trigger settings for "command word
		setup (type: address/word)"
	mode code setup	see trigger settings for "command word setup (type: mode code)"
	atatua word actua	
	status word setup command and data word setup	see trigger settings for "status word setup" see trigger settings for "command and data word setup"
		data word setup"
	error condition setup	all, sync, parity, manchester, timing

Protocol configuration	source		
	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4	
	bit rate	high (100 kbit/s), low (12.5 kbit/s), or user-defined in range 10 kbit/s to 1 Mbit/s	
	polarity	A leg, B leg, normal, inverted	
	label list	associate numeric label with symbolic ID; optional definition of ARINC word format in terms of availability of label-specific SDI and SSM fields	
	auto threshold setup	assisted threshold configuration	
Trigger	trigger event setup	word, label, label and data, error condition, transmission interval	
	word setup	word start, word stop	
	label setup	label (condition =, ≠, ≥, ≤, in range, out of range)	
	data setup	data pattern up to 23 bit long (condition =, ≠, ≥, ≤, in range, out of range); data bit offset; SDI (00,01,10,11); SSM (00,01,10,11); label list can be used to determine availability of trigger properties SSM and SDI for given label value	
	error condition setup	any combination of coding error, parity error, gap error	
	transmission interval setup	label (condition =); SDI (optional); time interval (condition >, <, in range, out of range)	
Decode	display signals	bus signal, logic signal or both; symbolic ID in bus signal when label list in use	
	color coding	word begin, word end, label, SDI, data, SSM, parity, error	
	displayed format of data	hex, decimal, binary, ASCII	
	frame table	decode results displayed as tabulated list, errors highlighted in red; frame navigation; data export as CSV file; column with symbolic ID when label list in use	
Search	search events	word, label, label and data, error condition	
	word setup	word start, word stop	
	label setup	see trigger settings for "label setup"	
	data setup	see trigger settings for "data setup"	
	error condition setup	coding error, parity error, gap error, any	

Power analysis General description	The R&S [®] RTA-K31 power analysis option extends the R&S [®] RTA firmware with measurement functionality focused on switched mode power supplies (SMPS) and		
	DC/DC converters.		
Input	quality	evaluation of power quality at an AC input; measures real power, apparent power, reactive power, power factor and phase angle of power, frequency, crest factor, RMS of voltage and current	
	harmonics	measures up to the 334 th harmonic of the incoming line frequency; precompliance checking for IEC 61000-3-2 (A, B, C, D), RTCA DO-160, MIL-STD-1399, max. limit checks	
	inrush current	measures peak inrush current and electrical charge within up to 3 configurable measurement zones to analyze the inrush and post-inrush behavior	
	consumption	long term measurement of consumed power and energy to analyze nonperiodical signals of e.g. standby devices	
Switching/control loop	slew rate	The minimum and maximum slew rate of current or voltage is measured at start and end of the switching cycle.	
	modulation	measures modulation of switching frequency, duty cycle (±) and pulse width	
	dynamic on-resistance	measures resistance of the switching transistor(s) in active state	
Power path	efficiency	measures input and output power to calculate the efficiency of a power device	
	switching loss	measures switching loss and conduction loss of a power device	
	safe operating area (SOA)	checks violation of voltage and current limits in which a power device can operat without damage; current versus voltage view (linear or log); violation mask is user defined and editable in linear and log-log views; save/load of masks; export of mas violation data	
	turn on/off time	measures relationship between AC and DC current, when turning SMPS off and on	
Output	ripple	measures AC components of output voltage or current, AC RMS, mean, period, frequency, duty cycles, min./max./peak-to-peak amplitude	
	spectrum	FFT analysis of output, measurement of frequency peaks	
	transient response	This measurement captures the device behavior between the event of load changes and stabilization; includes peak (voltage, time), settling time, rise time, overshoot and delay	
Deskew	automated	By using the R&S [®] RT-ZF20 probe deskew and calibration test fixture and Rohde & Schwarz voltage and current probes, the skew between the signals is compensated automatically.	
Zero offset	automated	automatic compensation of input offset	
Reporting	Report data can be saved for every measurement. Report generation using user- selected test results from historical and current tests. Put repeated and/or different measurements in one report. R&S®Oscilloscope Report Creator can be downloaded from Rohde & Schwarz website free-of-charge.		

R&S®RTA-K36

Frequency response analysis –	Bode plot (does not require R&S [®] RTA-B6 option)	1
Stimulus	frequency mode	single sweep or repeated sweep
	frequency range	10 Hz to 25 MHz
	amplitude mode	fixed or amplitude profile
	amplitude level	20 mV to 10 V into high Z
		10 mV to 5 V into 50 Ω
Input and output sources	R&S [®] RTA4004	channel 1, channel 2, channel 3,
		channel 4
Number of test points		10 points to 500 points per decade
Dynamic range		typ. > 70 dB based on 0 dBm
		(630 mV (V _{pp}) into 50 Ω,
		gain noise < 1 dB, phase noise < 5°)
Measurement		dual pair of tracking gain and phase
		cursors
Diagram types	manually changeable vertical window size	parallel display of result window and input
		and output signal view
Result table		navigation and export functions
Scaling	during and after test	auto-scale and manual scaling and
		positioning

R&S®RTA-K37

Spectrum analysis and spectrogra General	additional displays	spectrum traces and/or spectrogram	
Spectrum	sources		
opecium	R&S®RTA4004	channel 1, channel 2, channel 3, channel 4	
	setup parameters	center frequency, frequency span, automatic RBW, resolution bandwidth, gate position, gate width, vertical scale, vertical position	
	scaling	dBm, dBV, dBµV, V (RMS)	
	span	0.2 Hz to 1.2 GHz	
	resolution bandwidth	span/10 ≥ RBW ≥ span/1000	
	windows	flat top, Hanning, Hamming, Blackman, rectangular	
	trace types	normal, max. hold, min. hold, average	
Spectrogram	color	rainbow, temp. color, monochrome	
Marker	peak marker search	standard search parameter: min. level	
		advanced search parameter: min. level, excursion, maximum width, distance to next peak	
	reference marker	selection via index or frequency range	
	markers on peak	up to 100 markers	
	sources	any spectrum trace	
	table	frequency and magnitude, absolute or relative to reference marker	
	marker result display	indicated at wave form: level, frequency	
Cursor	measurements on spectrum traces	level, frequency, level and frequency, V marker	
	additional actions for cursor	coupling of cursors, set to trace, set to screen, track scaling, set next and previous peak	
Spectrogram measurements	two time cursor	t1, t2, delta t, total time, relative time between segments	

Ordering information

Designation	Туре	Order No.
Choose your R&S [®] RTA4000 base model		
Oscilloscope, 200 MHz, 4 channels	R&S [®] RTA4004	1335.7700.04
Base unit (including standard accessories: 500 MHz passive probe pe	er channel, power cord)	
Choose your bandwidth upgrade		
Upgrade of R&S®RTA4004 oscilloscopes to 350 MHz bandwidth	R&S [®] RTA-B243	1335.7846.02
Upgrade of R&S [®] RTA4004 oscilloscopes to 500 MHz bandwidth	R&S [®] RTA-B245	1335.7852.02
Upgrade of R&S®RTA4004 oscilloscopes to 1 GHz bandwidth	R&S [®] RTA-B2410	1335.7869.02
Choose your options		
Mixed signal upgrade for non-MSO models, 400 MHz	R&S [®] RTA-B1	1335.7823.02
Arbitrary waveform and 4-bit pattern generator	R&S [®] RTA-B6	1335.7830.02
I ² C/SPI serial triggering and decoding	R&S [®] RTA-K1	1335.7681.02
UART/RS-232/RS-422/RS-485 serial triggering and decoding	R&S [®] RTA-K2	1335.7698.02
CAN/LIN serial triggering and decoding	R&S [®] RTA-K3	1335.7717.02
Audio (I ² S, LJ, RJ, TDM) triggering and decoding	R&S [®] RTA-K5	1335.7723.02
MIL-STD-1553 serial triggering and decoding	R&S [®] RTA-K6	1335.7730.02
ARINC 429 serial triggering and decoding	R&S [®] RTA-K7	1335.7746.02
Power analysis	R&S [®] RTA-K31	1335.7769.02
Frequency response analysis (Bode plot)	R&S [®] RTA-K36	1335.7975.02
Spectrum analysis and spectrogram	R&S [®] RTA-K37	1335.7981.02
Application bundle ⁴ , consists of the following options:	R&S [®] RTA-PK1	1335.7775.02
R&S [®] RTA-K1, R&S [®] RTA-K2, R&S [®] RTA-K3, R&S [®] RTA-K5,		
R&S [®] RTA-K6, R&S [®] RTA-K7, R&S [®] RTA-K31, R&S [®] RTA-K36,		
R&S [®] RTA-K37, R&S [®] RTA-B6		
Application bundle ⁵ , consists of the following options:	R&S [®] RTA-PK1US	1335.7998.02
R&S [®] RTA-K1, R&S [®] RTA-K2, R&S [®] RTA-K3, R&S [®] RTA-K5,		
R&S [®] RTA-K6, R&S [®] RTA-K7, R&S [®] RTA-K31, R&S [®] RTA-K36,		
R&S [®] RTA-K37, R&S [®] RTA-B6		
Choose your additional probes		
Single-ended passive probes		
500 MHz, 10 MΩ, 10:1, 300 V, 10 pF, 5 mm	R&S [®] RT-ZP05S	1333.2401.02
500 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S [®] RT-ZP10	1409.7550.00
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm	R&S [®] RT-ZP1X	1333.1370.02
Active broadband probes: single-ended		1000.1010.02
1.0 GHz, 10:1, 1 M Ω , BNC interface	R&S®RT-ZS10L	1333.0815.02
1.0 GHz, active, 1 M Ω , Rohde & Schwarz probe interface	R&S®RT-ZS10E	1418.7007.02
1.0 GHz, active, 1 MΩ, R&S [®] ProbeMeter, micro button,	R&S®RT-ZS10	1410.4080.02
Rohde & Schwarz probe interface		1410.4000.02
1.5 GHz, active, 1 M Ω , R&S [®] ProbeMeter, micro button,	R&S®RT-ZS20	1410.3502.02
Rohde & Schwarz probe interface	100 11-2020	1410.3302.02
Active broadband probes: differential		
1.0 GHz, active, differential, 1 MΩ, R&S [®] ProbeMeter, micro button,	R&S [®] RT-ZD10	1410.4715.02
incl. 10:1 external attenuator, 1 M Ω , 70 V DC, 46 V AC (peak),		1410.4715.02
Rohde & Schwarz probe interface		
1.5 GHz, active, differential, 1 M Ω , R&S [®] ProbeMeter, micro button,	R&S [®] RT-ZD20	1410 4409 02
	NOS NI-2020	1410.4409.02
Rohde & Schwarz probe interface		
Power rail probe		1800 5000 00
2.0 GHz, 1:1, 50 kΩ, ±0.85 V, ±60 V offset, Rohde & Schwarz probe	R&S [®] RT-ZPR20	1800.5006.02
interface		
High voltage single-ended passive probes		4000 0070 00
250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF	R&S®RT-ZH03	1333.0873.02
400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF	R&S®RT-ZH10	1409.7720.02
400 MHz, 1000:1, 50 MΩ, 1000 V, 7.5 pF	R&S [®] RT-ZH11	1409.7737.02

 $^{^4~}$ The R&S $^{\! \ensuremath{\otimes}} RTA\mbox{-} PK1$ option is not distributed in North America.

⁵ The R&S[®]RTA-PK1US option is only distributed in North America.

Designation	Туре	Order No.
High voltage probes: differential		
25 MHz, 20:1/200:1, 4 MΩ, 1.4 kV (CAT III), BNC interface	R&S [®] RT-ZD002	1337.9700.02
25 MHz, 10:1/100:14 MΩ, 700 V (CAT II), BNC interface	R&S [®] RT-ZD003	1337.9800.02
100 MHz, 8 MΩ, 1 kV (RMS) (CAT III), BNC interface	R&S [®] RT-ZD01	1422.0703.02
200 MHz, 10:1, ±20 V, BNC interface	R&S [®] RT-ZD02	1333.0821.02
800 MHz, 10:1, 200 kΩ, ±15 V, BNC interface	R&S [®] RT-ZD08	1333.0838.02
200 MHz, 250:1/25:1, 5 MΩ, 750 V (peak), 300 V CAT III,	R&S [®] RT-ZHD07	1800.2307.02
Rohde & Schwarz probe interface		
100 MHz, 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S [®] RT-ZHD15	1800.2107.02
Rohde & Schwarz probe interface		
200 MHz, 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S [®] RT-ZHD16	1800.2207.02
Rohde & Schwarz probe interface		
100 MHz, 1000:1/100:1, 40 MΩ, 6000 V (peak), 1000 V CAT III,	R&S®RT-ZHD60	1800.2007.02
Rohde & Schwarz probe interface		
Current probes		1
20 kHz, AC/DC, 0.01 V/A and 0.001 V/A, ±200 A and ±2000 A,	R&S [®] RT-ZC02	1333.0850.02
BNC interface		
100 kHz, AC/DC, 0.1 V/A, 30 A, BNC interface	R&S®RT-ZC03	1333.0844.02
2 MHz, AC/DC, 0.01 V/A, 500 A (RMS), Rohde & Schwarz probe	R&S [®] RT-ZC05B	1409.8204.02
interface		
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), BNC interface	R&S [®] RT-ZC10	1409.7750K02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC10B	1409.8210.02
interface		
50 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC15B	1409.8227.02
interface		
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), BNC interface	R&S [®] RT-ZC20	1409.7766K02
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC20B	1409.8233.02
interface		
120 MHz, AC/DC, 1 V/A, 5 A (RMS), BNC interface	R&S®RT-ZC30	1409.7772K02
EMC near-field probes		
Probe set for E and H near-field measurements, 30 MHz to 3 GHz	R&S [®] HZ-15	1147.2736.02
Logic probes		
400 MHz logic probe, 8 channels	R&S®RT-ZL04	1333.0721.02
Probe accessories		
Probe power supply for R&S [®] RT-ZC10/20/30	R&S [®] RT-ZA13	1409.7789.02
External attenuator 10:1, 2.0 GHz, 1.3 pF, 60 V DC,	R&S®RT-ZA15	1410.4744.02
42.4 V AC (peak) for R&S $^{\circ}$ RT-ZD20/30 probes		
Probe pouch	R&S [®] RT-ZA19	
Power deskew and calibration test fixture	R&S [®] RT-ZF20	1800.0004.02
3D positioner with central tensioning knob for easy clamping and	R&S®RT-ZA1P	1326.3641.02
positioning of probes (span width: 200 mm, clamping range: 15 mm)		1020.0041.02
Choose your accessories		
Front cover	R&S [®] RTB-Z1	1333.1728.02
Soft bag	R&S®RTB-Z3	1333.1728.02
Transit case	R&S®RTB-Z4	1335.9290.02
	Nag NID-24	1000.9290.02

Warranty		
Base unit		3 years
All other items ⁶		1 year
Service options		
Extended warranty, one year	R&S [®] WE1	Please contact your local Rohde & Schwarz sales office.
Extended warranty, two years	R&S [®] WE2	
Extended warranty with calibration coverage, one year	R&S [®] CW1	
Extended warranty with calibration coverage, two years	R&S [®] CW2	
Extended warranty with accredited calibration coverage,	R&S [®] AW1	
one year		
Extended warranty with accredited calibration coverage,	R&S [®] AW2	
two years		

Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge ⁷. Necessary calibration and adjustments carried out during repairs are also covered.

Extended warranty with calibration (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs ⁷ and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs ⁷ and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

⁶ For options that are installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

⁷ Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

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 Uncompromising quality
 Long-term dependability



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